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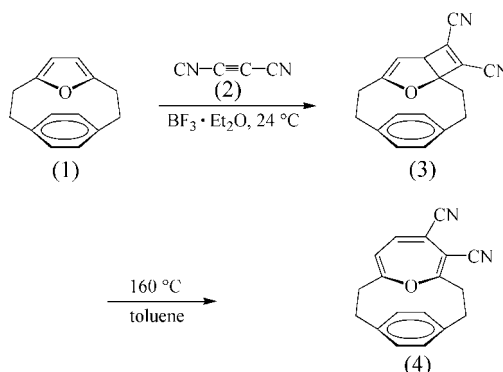
## Key indicators

Single-crystal X-ray study  
 $T = 178\text{ K}$   
Mean  $\sigma(\text{C}-\text{C}) = 0.006\text{ \AA}$   
 $R$  factor = 0.068  
 $wR$  factor = 0.219  
Data-to-parameter ratio = 12.7For details of how these key indicators were  
automatically derived from the article, see  
<http://journals.iucr.org/e>.[2.2](2,7)Oxepinoparacyclophane-  
4,5-dicarbonitrile

In the title compound,  $\text{C}_{18}\text{H}_{14}\text{N}_2\text{O}$ , the O atom of the oxepine ring lies above the six-membered ring [3.008 (4) Å from the plane of the non-bridgehead atoms], but the rest of the oxepine ring is bent away from that plane and thus away from the molecule. Three  $\text{C}-\text{H} \cdots \text{N}$  contacts connect the molecules to form layers parallel to the  $ac$  plane.

## Comment

When dicyanoacetylene (2) is added to [2.2](2,5)furanocyclophane, (1), in the presence of  $\text{BF}_3$ -etherate at room temperature, the [2+2]-cycloadduct (3) is formed in low yield (7%) (Witulski, 1992). To confirm its structure, we heated this addition product in toluene solution at 433 K and observed the expected ring opening to the oxepinophane (4), accompanied by a colour change to deep red (yield 68%; Witulski, 1992). We report here the structure of (4).



The molecule of (4) is shown in Fig. 1. Except for the carbonitrile substituents, the molecule shows approximate mirror symmetry. The six-membered ring shows the flattened boat form typical of paracyclophanes, whereby atom C11 lies

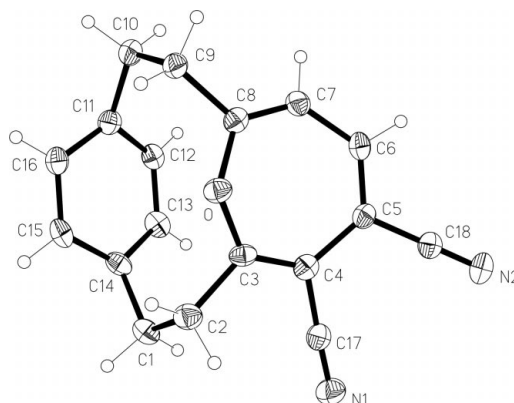
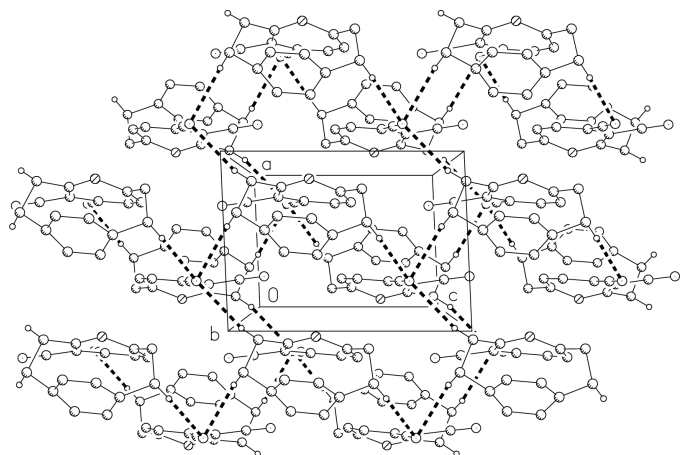


Figure 1

The molecule of compound (4) in the crystal. Ellipsoids are drawn at the 30% probability level and H-atom radii are arbitrary.



**Figure 2**

Packing diagram of compound (4). Hydrogen bonds are shown as thick dashed lines. H atoms not involved in hydrogen bonds have been omitted.

0.172 (6) Å and C14 0.152 (6) Å out of the plane of the other four atoms. The oxepine ring is non-planar, with absolute torsion angles of *ca* 31° about the bonds involving the O atom (and of *ca* 17° about C4–C5 and C6–C7). The net effect is that the O atom lies above the six-membered ring [3.008 (4) Å from the C12/C13/C15/C16 plane], but the rest of the oxepine ring is bent away from the six-membered ring and thus away from the molecule as a whole.

Three non-bonded contacts of the type C–H···N could be interpreted as weak hydrogen bonds (Table 2). The overall effect of these is to produce thick layers of molecules parallel to the *ac* plane (Fig. 2) in the regions  $y \simeq 0, \frac{1}{2}, 1$ , etc.

## Experimental

Compound (4) was prepared as described above, isolated by thick-layer chromatography (Witulski, 1992), and recrystallized from chloroform/pentane.

### Crystal data

C<sub>18</sub>H<sub>14</sub>N<sub>2</sub>O  
*M<sub>r</sub>* = 274.31  
 Monoclinic, *P*<sub>2</sub><sub>1</sub>/*n*  
*a* = 6.494 (3) Å  
*b* = 23.899 (12) Å  
*c* = 8.783 (4) Å  
 $\beta$  = 92.48 (4)°  
*V* = 1361.8 (11) Å<sup>3</sup>  
*Z* = 4

*D<sub>x</sub>* = 1.338 Mg m<sup>−3</sup>  
 Mo *K*α radiation  
 Cell parameters from 49 reflections  
 $\theta$  = 10–11.5°  
 $\mu$  = 0.08 mm<sup>−1</sup>  
*T* = 178 (2) K  
 Column, red  
 0.65 × 0.20 × 0.20 mm

### Data collection

Nicolet R3 diffractometer  
 $\omega$  scans  
 2567 measured reflections  
 2409 independent reflections  
 1211 reflections with  $I > 2\sigma(I)$   
*R<sub>int</sub>* = 0.023  
 $\theta_{\max}$  = 25.0°

*h* = −7 → 7  
*k* = −28 → 30  
*l* = 0 → 10  
 3 standard reflections  
 every 147 reflections  
 intensity decay: none

### Refinement

Refinement on *F*<sup>2</sup>  
 $R[F^2 > 2\sigma(F^2)] = 0.068$   
 $wR(F^2) = 0.219$   
*S* = 0.93  
 2409 reflections  
 190 parameters

H-atom parameters constrained  
 $w = 1/[\sigma^2(F_o^2) + (0.13P)^2]$   
 where  $P = (F_o^2 + 2F_c^2)/3$   
 $(\Delta/\sigma)_{\max} < 0.001$   
 $\Delta\rho_{\max} = 0.28 \text{ e \AA}^{-3}$   
 $\Delta\rho_{\min} = -0.27 \text{ e \AA}^{-3}$

**Table 1**

Selected geometric parameters (Å, °).

O–C3	1.364 (5)	C1–C2	1.547 (6)
O–C8	1.415 (5)	C9–C10	1.571 (6)
C3–O–C8	127.4 (3)	C8–C9–C10	114.7 (3)
C14–C1–C2	106.0 (3)	C11–C10–C9	105.5 (3)
C3–C2–C1	114.8 (3)		
C14–C1–C2–C3	−51.7 (5)	C5–C6–C7–C8	17.1 (7)
C8–O–C3–C4	30.9 (6)	C6–C7–C8–O	−0.6 (7)
O–C3–C4–C5	0.4 (7)	C3–O–C8–C7	−30.8 (6)
C3–C4–C5–C6	−17.1 (7)	C8–C9–C10–C11	53.0 (5)
C4–C5–C6–C7	0.1 (7)		

**Table 2**

Hydrogen-bonding geometry (Å, °).

<i>D</i> –H··· <i>A</i>	<i>D</i> –H	H··· <i>A</i>	<i>D</i> ··· <i>A</i>	<i>D</i> –H··· <i>A</i>
C1–H1A···N2 <sup>i</sup>	0.99	2.66	3.541 (6)	148
C2–H2B···N2 <sup>ii</sup>	0.99	2.70	3.582 (6)	149
C10–H10B···N2 <sup>iii</sup>	0.99	2.66	3.649 (6)	177

Symmetry codes: (i) 1 − *x*, 1 − *y*, 2 − *z*; (ii) −*x*, 1 − *y*, 2 − *z*; (iii) 1 − *x*, 1 − *y*, 1 − *z*.

H atoms were included using a riding model with fixed C–H bond lengths (*sp*<sup>2</sup> C–H = 0.95 Å and methylene C–H = 0.99 Å); *U*<sub>iso</sub>(H) values were fixed at 1.2*U*<sub>eq</sub> of the parent atom.

Data collection: *P3* (Nicolet, 1987); cell refinement: *P3*; data reduction: *XDISK* (Nicolet, 1987); program(s) used to solve structure: *SHELXS97* (Sheldrick, 1990); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *XP* (Siemens, 1994); software used to prepare material for publication: *SHELXL97*.

Financial support from the Fonds der Chemischen Industrie is gratefully acknowledged. We thank Mr A. Weinkauff for technical assistance.

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